

Notice of References Cited	Application/Control No. 10/527,795		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Bernard Lipman		Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	E	US-6,956,010	10-2005	Tsukida et al.	503/200
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NON-PATENT DOCUMENTS

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